

RoHS Compliant Product
A Suffix of "C" specifies halogen & lead-free

DESCRIPTIONS

The SSI2154 is N-Channel enhancement MOS Field Effect Transistor. Uses advanced trench technology and design to provide excellent RDS (ON) with low gate charge. This device is suitable for use in DC-DC conversion, load switch and level shift.

MECHANICAL DATA

- Trench Technology
- Supper high density cell design
- Excellent ON resistance
- Extremely Low Threshold Voltage

APPLICATION

- DC-DC converter circuit
- Load Switch

DEVICE MARKING:

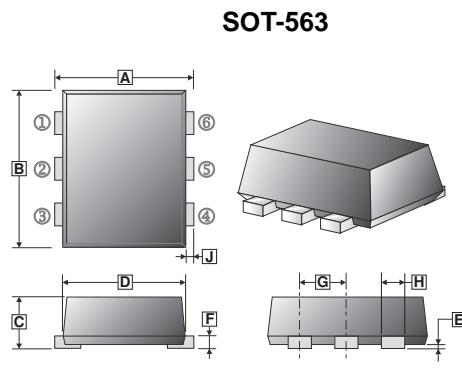
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PACKAGE INFORMATION

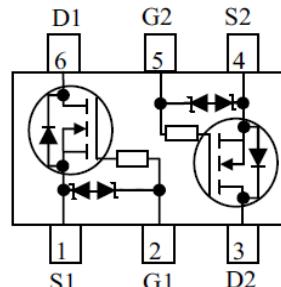
Package	MPQ	Leader Size
SOT-563	3K	7' inch

MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Rating		Unit
		10S	Steady State	
Drain – Source Voltage	V_{DS}		20	V
Gate – Source Voltage	V_{GS}		± 6	V
Continuous Drain Current ¹	I_D	0.88	0.8	A
		0.71	0.64	
Power Dissipation ¹	P_D	0.37	0.3	W
		0.23	0.19	
Continuous Drain Current ²	I_D	0.76	0.69	A
		0.6	0.55	
Power Dissipation ²	P_D	0.27	0.22	W
		0.17	0.14	
Pulsed Drain Current ³	I_{DM}		1.4	A
Maximum Junction-to-Lead	$R_{\theta JL}$		260	$^\circ\text{C} / \text{W}$
Operating Junction & Storage Temperature Range	T_J, T_{STG}		-55~150	$^\circ\text{C}$



REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	1.50	1.70	F	0.09	0.16
B	1.50	1.70	G	0.45	0.55
C	0.525	0.60	H	0.17	0.27
D	1.10	1.30	J	0.10	0.30
E	-	0.05			



THERMAL RESISTANCE RATINGS

Parameter	Symbol	Rating		Unit
		Typ.	Max.	
Single Operation				
Junction-to-Ambient Thermal Resistance ¹	T \leq 10S	R _{θJA}	285	335
	Steady State		340	405
Junction-to-Ambient Thermal Resistance ²	T \leq 10S	R _{θJA}	385	450
	Steady State		455	545
Junction-to-Case Thermal Resistance	Steady State	R _{θJC}	260	300
Dual Operation				
Junction-to-Ambient Thermal Resistance ¹	T \leq 10S	R _{θJA}	315	365
	Steady State		370	440
Junction-to-Ambient Thermal Resistance ²	T \leq 10S	R _{θJA}	420	490
	Steady State		505	585
Junction-to-Case Thermal Resistance	Steady State	R _{θJC}	265	305

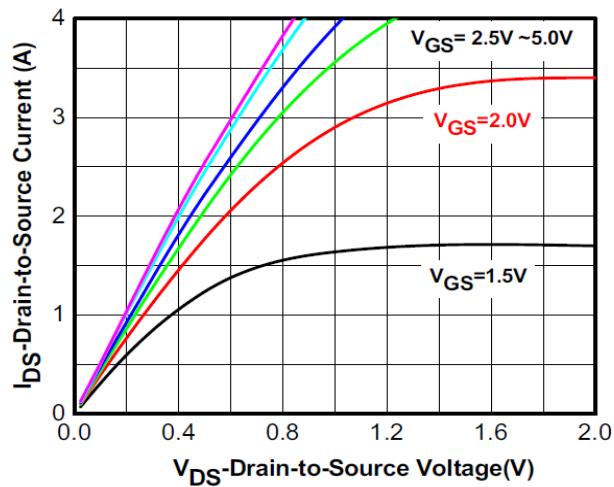
Note:

1. Surface mounted on FR4 Board using 1 square inch pad size, 1oz copper.
2. Surface mounted on FR4 board using minimum pad size, 1oz copper
3. Repetitive rating, pulse width limited by junction temperature, tp=10μs, Duty Cycle=1%
4. Repetitive rating, pulse width limited by junction temperature TJ=150°C.

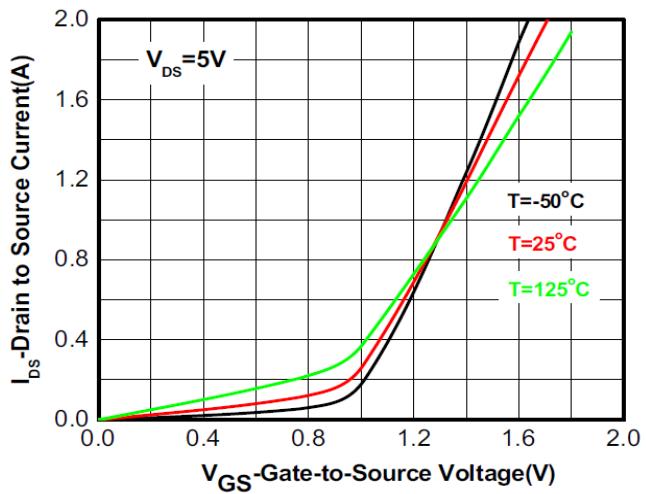
ELECTRICAL CHARACTERISTICS (T_A=25°C unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static						
Drain-Source Breakdown Voltage	V _{(BR)DSS}	20	-	-	V	V _{GS} =0, I _D =250μA
Zero Gate Voltage Drain Current	I _{DSS}	-	-	1	μA	V _{DS} =16V, V _{GS} =0
Gate-Source Leakage	I _{GSS}	-	-	± 5	μA	V _{DS} =0, V _{GS} = ± 5 V
Gate-Threshold Voltage	V _{GS(TH)}	0.45	0.58	0.85	V	V _{DS} =V _{GS} , I _D =250μA
Drain-Source On Resistance	R _{DS(ON)}	-	220	310	mΩ	V _{GS} =4.5V, I _D =0.55A
		-	260	360		V _{GS} =2.5V, I _D =0.45A
		-	320	460		V _{GS} =1.8V, I _D =0.35A
Forward Transconductance	g _{FS}	-	2	-	S	V _{DS} =5V, I _D = 0.55A
Body-Drain Diode Ratings						
Diode Forward On-Voltage	V _{SD}	0.5	0.7	1.5	V	I _S =350mA, V _{GS} =0
Dynamic Characteristics						
Input Capacitance	C _{ISS}	-	60	-	pF	V _{DS} =10V, V _{GS} =0, f=100KHz
Output Capacitance	C _{OSS}	-	11	-		
Reverse Transfer Capacitance	C _{RSS}	-	7.5	-		
Total Gate Charge	Q _{G(TOT)}	-	1.15	-	nC	V _{DS} =10V, V _{GS} =4.5V, I _D =0.55A
Threshold Gate Charge	Q _{G(TH)}	-	0.06	-		
Gate-to-Source Charge	Q _{GS}	-	0.15	-		
Gate-to-Drain Charge	Q _{GD}	-	0.23	-		
Turn-on Delay Time	T _{d(ON)}	-	22	-	ns	V _{DD} =10V, I _D =0.55A, V _{GS} =4.5V, R _G =6Ω
Rise Time	T _r	-	80	-		
Turn-off Delay Time	T _{d(OFF)}	-	700	-		
Fall Time	T _f	-	380	-		

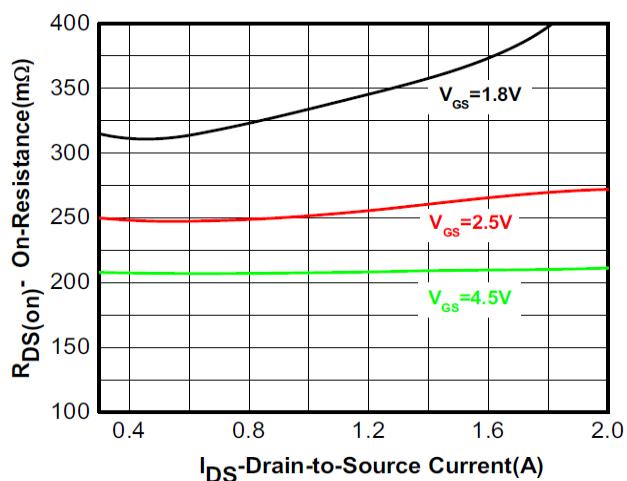
CHARACTERISTIC CURVES



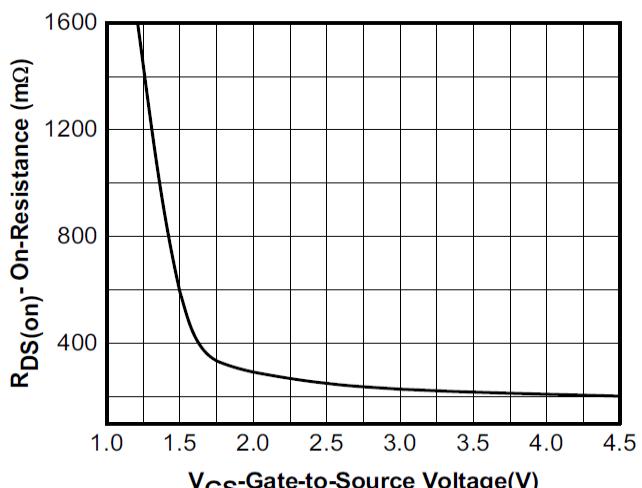
Output characteristics



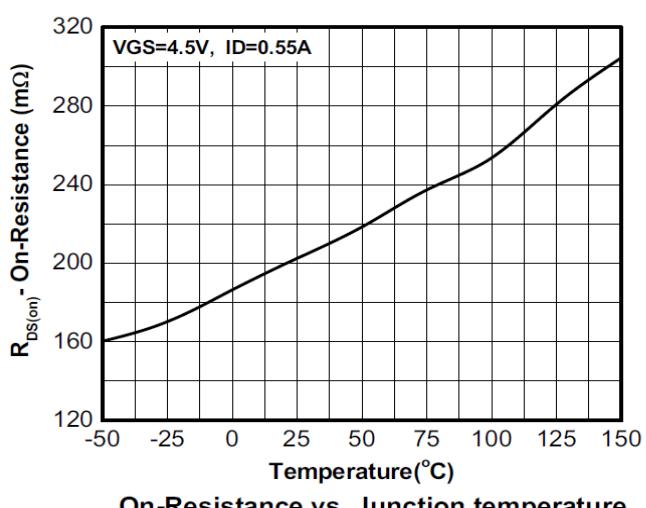
Transfer characteristics



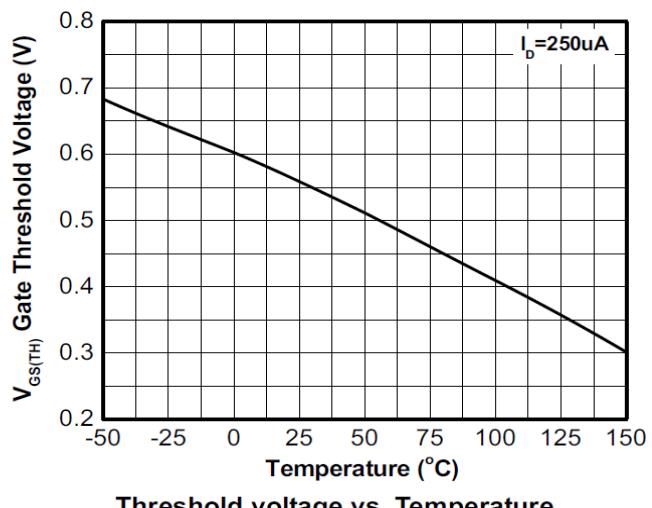
On-Resistance vs. Drain current



On-Resistance vs. Gate-to-Source voltage

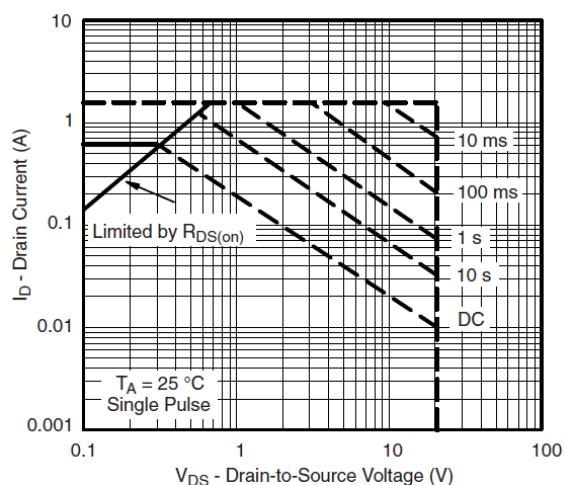
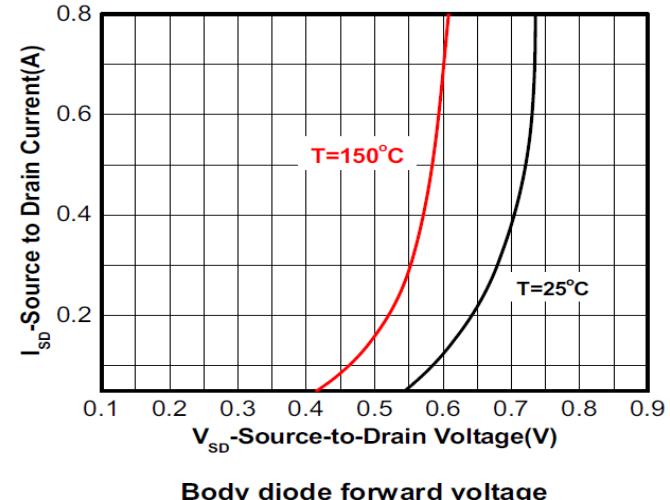
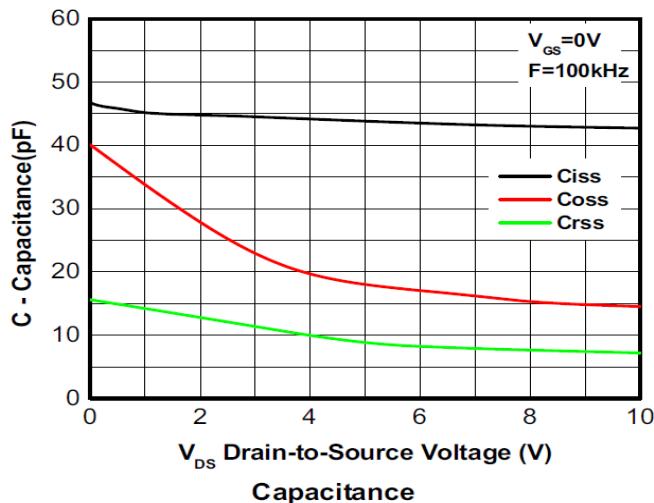


On-Resistance vs. Junction temperature

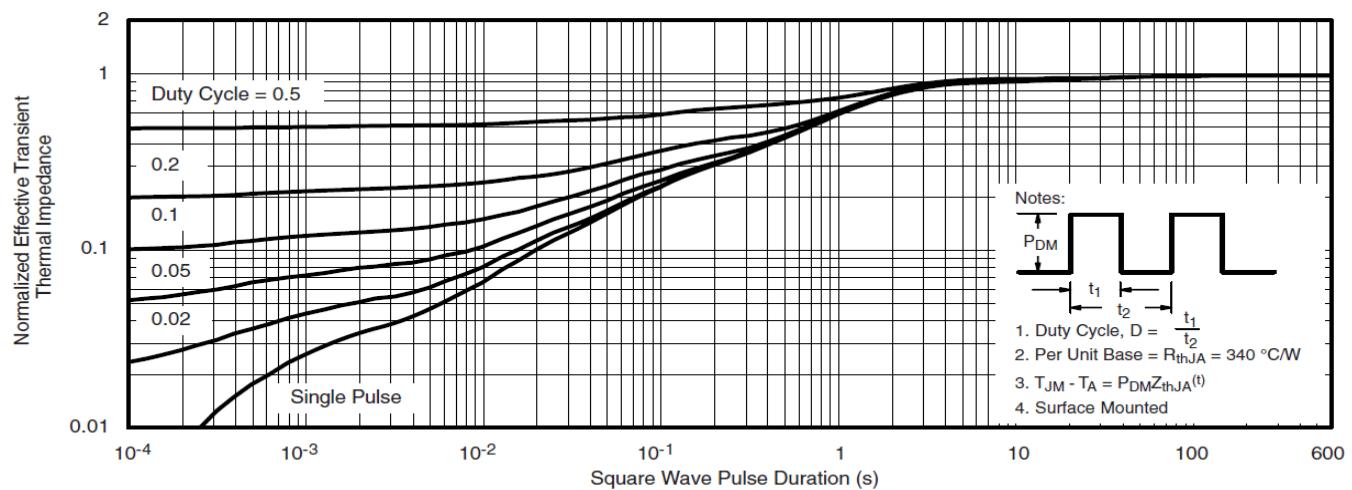


Threshold voltage vs. Temperature

CHARACTERISTIC CURVES



Safe operating power



Transient thermal response (Junction-to-Ambient)